## Notice of References Cited Application/Control No. 10/534,871 Examiner Todd M. Epps Applicant(s)/Patent Under Reexamination YAMASHITA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,293,392	09-2001	Galbierz, Michael A.	206/148
	В	US-5,320,216	06-1994	Pangborn, Dominic	206/158
	С	US-5,323,895	06-1994	Sutherland et al.	206/147
	Ð	US-5,487,464	01-1996	Galbierz et al.	206/149
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-		-	
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP08310557	11-1996	Japan	Kunji	
	0					
	Ρ					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
·	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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